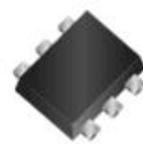


## **WCM2007**

**N- and P-Channel, 20V, MOSFET**

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

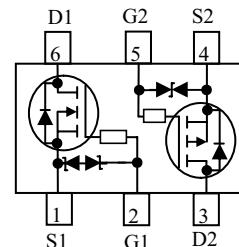
$V_{(BR)DSS}$	$R_{DS(on)}$ Typical. ( $\Omega$ )
N-Channel 20 V	0.18@ 4.5V
	0.23@ 2.5V
	0.30@ 1.8V
ESD protection	
P-Channel -20 V	0.45@ -4.5V
	0.60@ -2.5V
	0.75@ -1.8V
ESD protection	



**SOT-563**

### **Descriptions**

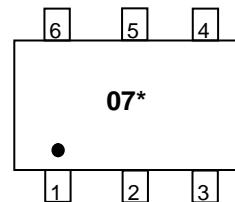
The WCM2007 is the N- and P-Channel enhancement MOS Field Effect Transistor as a single package for DC-DC converter or level shift applications, uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. Standard Product WCM2007 is Pb-free.



**Pin configuration (Top view)**

### **Features**

- Trench Technology
- Supper high density cell design for extremely low  $R_{ds(on)}$
- Exceptional ON resistance and maximum DC current capability
- Small package design with SOT-563.



07 = Device Code

\* = Date Code

### **Marking**

### **Applications**

- Driver: Relays, Solenoids, Lamps, Hammers
- Power supply converters circuit
- Load/Power Switching for potable device

### **Order Information**

Device	Package	Shipping
WCM2007-6/TR	SOT-563	3000/Tape&Reel

**Absolute Maximum Ratings**

(T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	N-Channel		P-Channel		Unit
		10 s	Steady State	10 s	Steady State	
Drain-Source Voltage	V <sub>DS</sub>	+20		-20		V
Gate-Source Voltage	V <sub>GS</sub>	$\pm 6$		$\pm 6$		V
Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	0.89	0.79	-0.56	-0.50
	T <sub>A</sub> =70°C		0.71	0.63	-0.45	-0.40
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	0.37	0.29	0.37	0.29
	T <sub>A</sub> =70°C		0.23	0.18	0.23	0.18
Continuous Drain Current <sup>b</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	0.76	0.69	-0.48	-0.44
	T <sub>A</sub> =70°C		0.61	0.55	-0.38	-0.35
Maximum Power Dissipation <sup>b</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	0.27	0.22	0.27	0.22
	T <sub>A</sub> =70°C		0.17	0.14	0.17	0.14
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>	1.4		-1.0		A
Operating Junction Temperature	T <sub>J</sub>	150		$\circ\text{C}$		$\circ\text{C}$
Lead Temperature	T <sub>L</sub>	260		$\circ\text{C}$		$\circ\text{C}$
Storage Temperature Range	T <sub>stg</sub>	-55 to 150		$\circ\text{C}$		$\circ\text{C}$

**Thermal resistance ratings**

Parameter		Symbol	Typical	Maximum	
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 10 s	R <sub>θJA</sub>	290	335	$\circ\text{C/W}$
	Steady State		340	430	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t ≤ 10 s	R <sub>θJA</sub>	385	460	
	Steady State		465	555	
Junction-to-Case Thermal Resistance	Steady State	R <sub>θJC</sub>	280	320	

a Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper

b Surface mounted on FR4 board using minimum pad size, 1oz copper

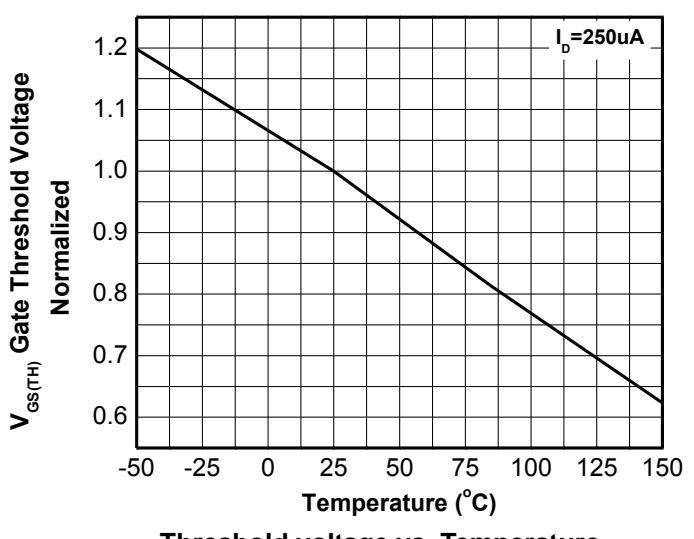
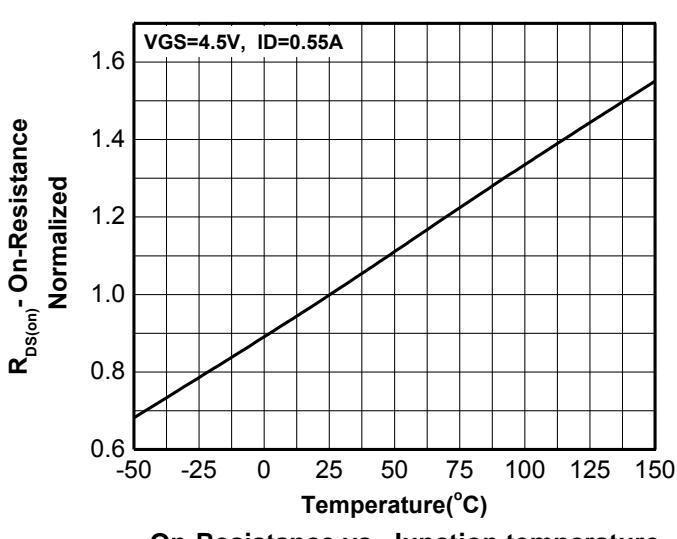
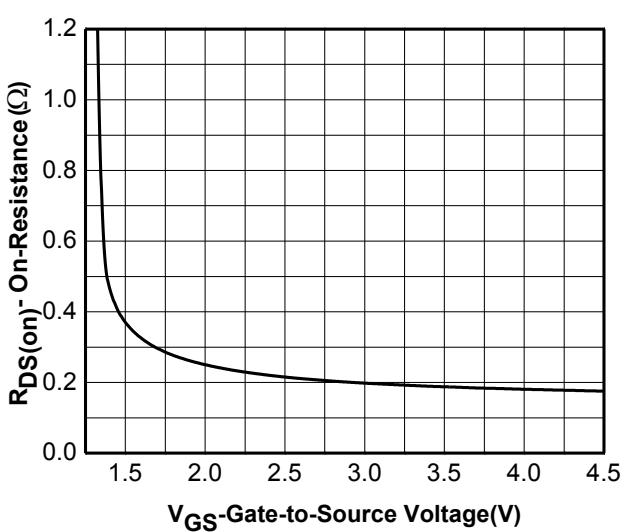
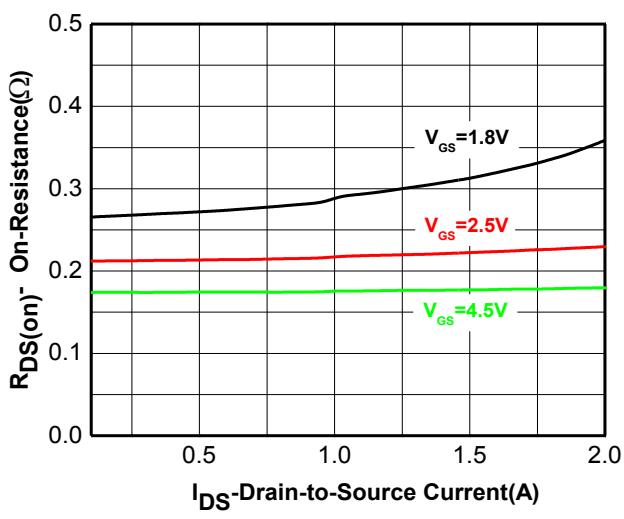
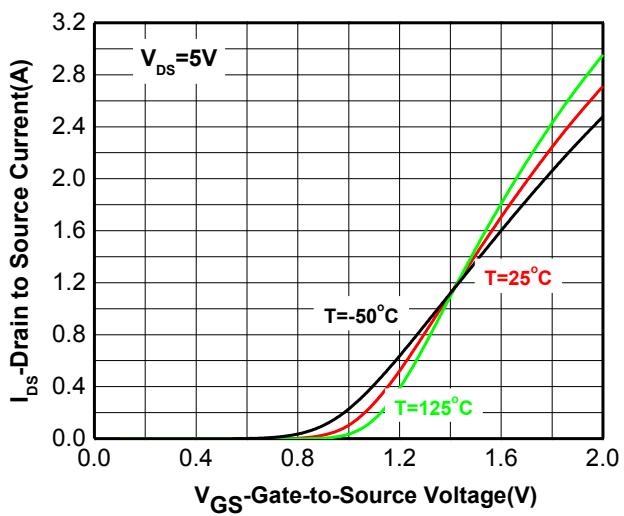
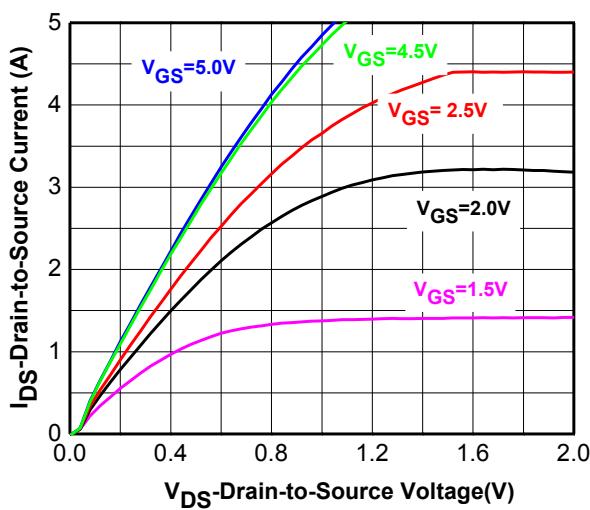
c Repetitive rating, pulse width limited by junction temperature, Pulse width&lt;380μs, Duty Cycle&lt;2%

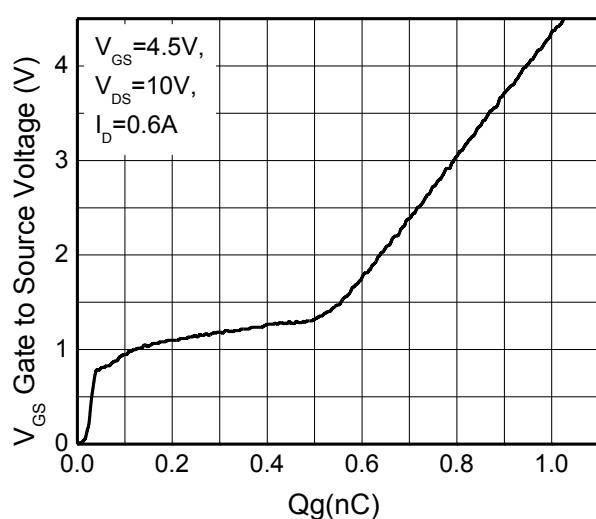
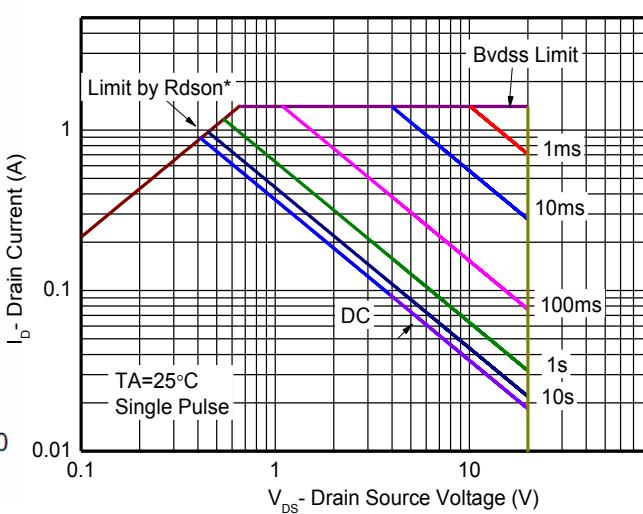
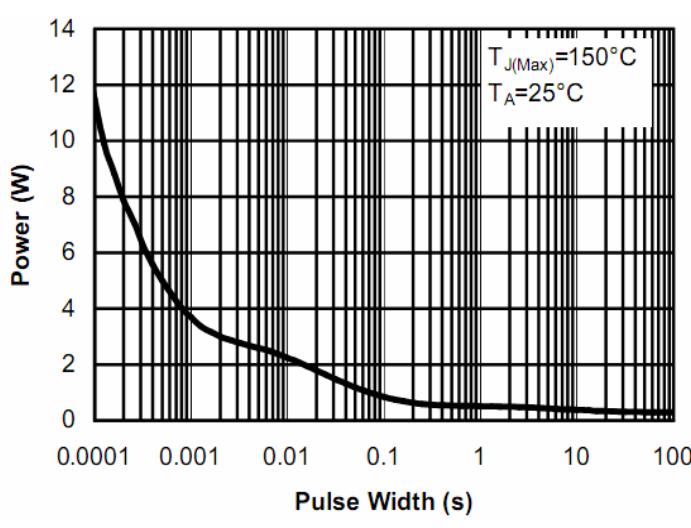
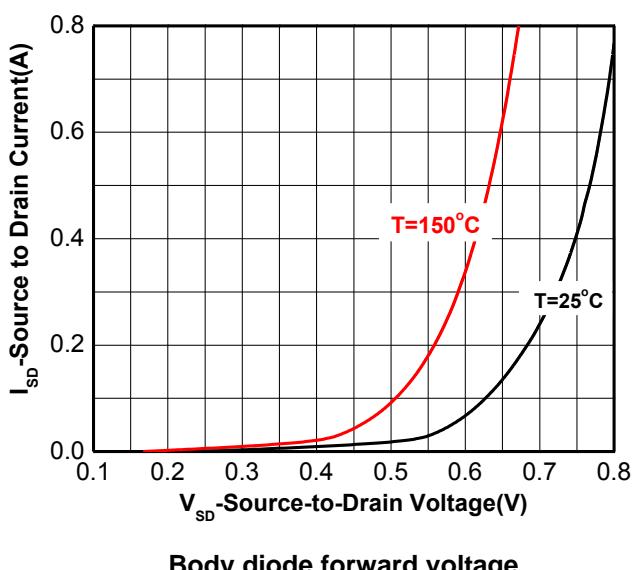
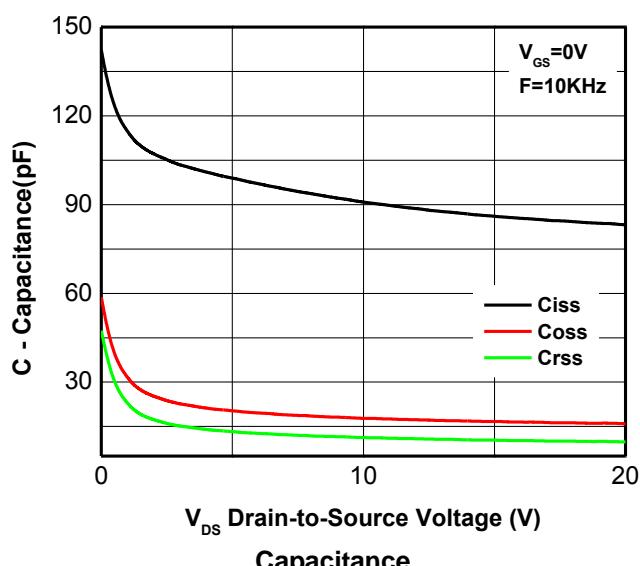
d Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>=150°C.

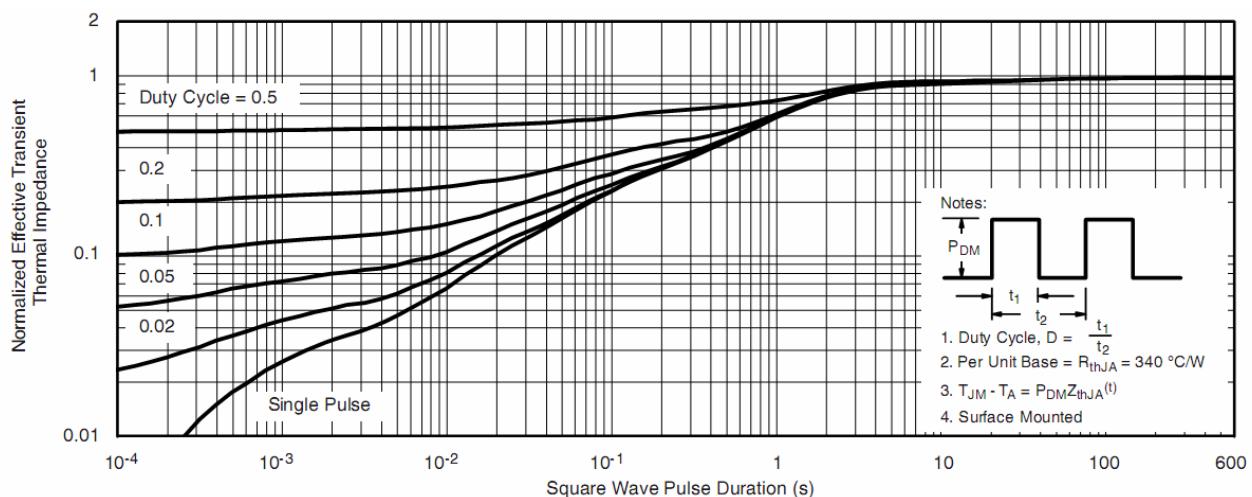
**Electronics Characteristics**
 $(T_A=25^\circ C$  unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ.	Max	Unit
<b>Off Characteristics</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	N-Ch	20		
		V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	P-Ch	-20		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>S</sub> =0V	N-Ch		+1	
		V <sub>DS</sub> =-20V, V <sub>S</sub> =0V	P-Ch		-1	
I <sub>GSS</sub>	Gate -Source leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±5V	N-Ch		±5	
			P-Ch		±5	
<b>ON Characteristics</b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250uA	N-Ch	0.40	0.72	0.90
		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =-250uA	P-Ch	-0.40	-0.62	-0.90
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.55A	N-Ch		0.18	0.31
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.45A	P-Ch		0.45	0.81
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =0.45A	N-Ch		0.23	0.36
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-0.35A	P-Ch		0.60	1.050
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =0.35A	N-Ch		0.30	0.46
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-0.25A	P-Ch		0.75	1.30
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 0.55A	N-Ch		2.0	
		V <sub>DS</sub> = -5 V, I <sub>D</sub> = -0.45A	P-Ch		1.25	
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	NMOS: V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, F=10KHz PMOS: V <sub>DS</sub> =-10V, V <sub>GS</sub> =0V, F=10KHz	N-Ch		90	
C <sub>oss</sub>	Output Capacitance		P-Ch		65.8	
C <sub>rss</sub>	Reverse Transfer Capacitance		N-Ch		17.7	
			P-Ch		19.8	
			N-Ch		11.2	
			P-Ch		7.7	
Q <sub>G(TOT)</sub>	Total Gate Charge	NMOS: V <sub>DS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.6A PMOS: V <sub>DS</sub> =-10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.6A	N-Ch		1.05	
Q <sub>G(TH)</sub>	Threshold Gate Charge		P-Ch		0.90	
Q <sub>GS</sub>	Gate-Source Charge		N-Ch		0.06	
			P-Ch		0.05	
			N-Ch		0.12	
			P-Ch		0.10	
Q <sub>GD</sub>	Gate-Drain Charge		N-Ch		0.38	
			P-Ch		0.44	

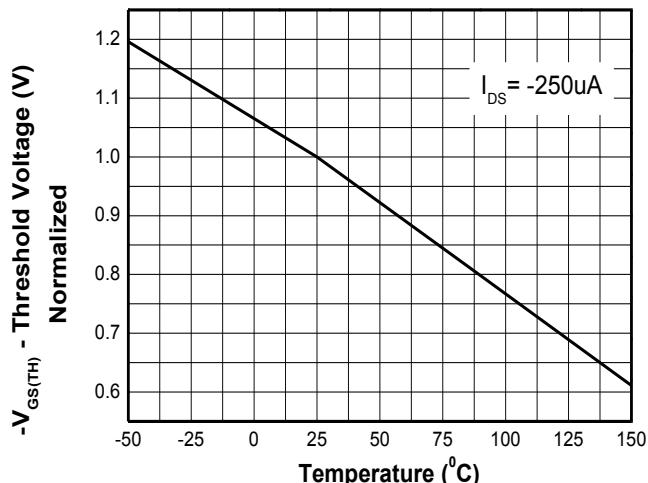
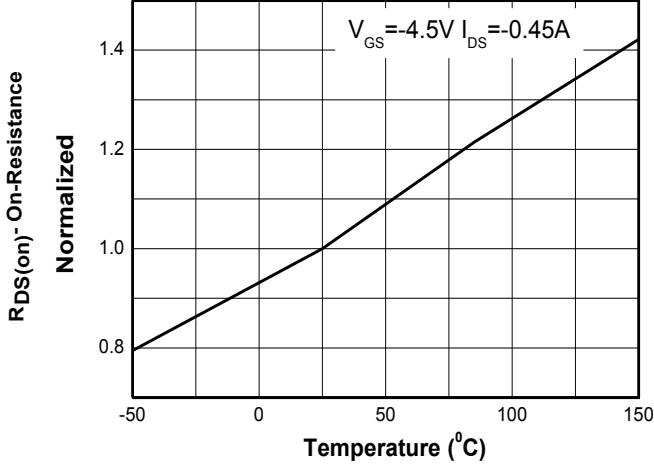
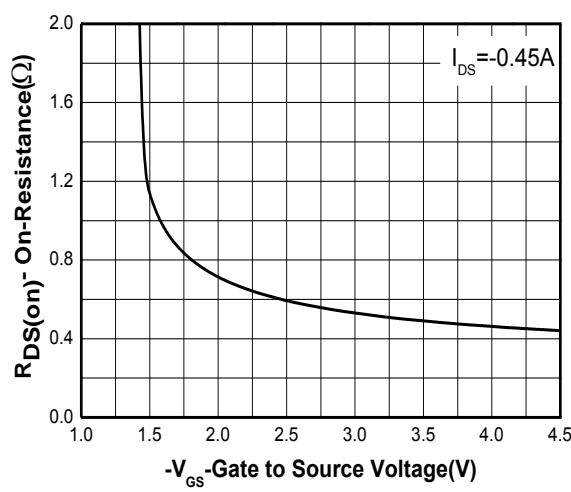
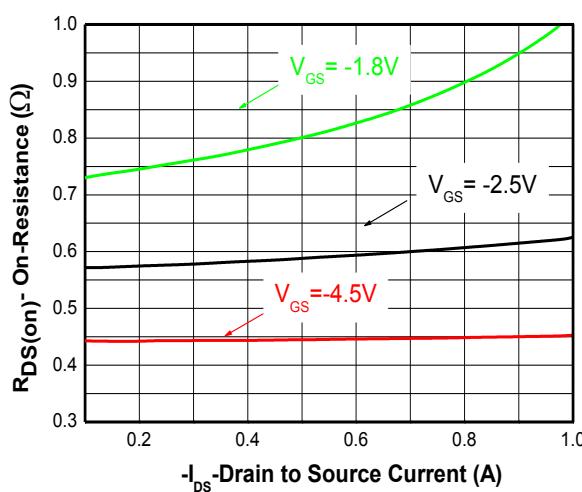
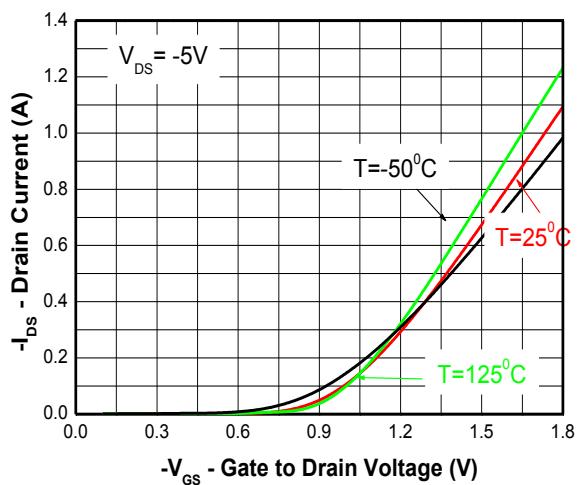
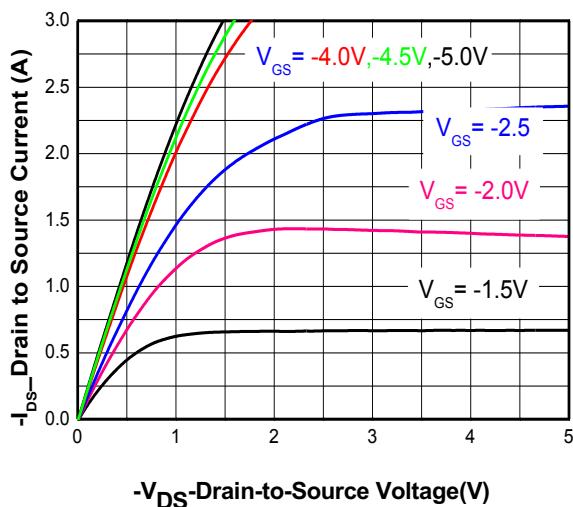
Symbol	Parameter	Test Condition	Min	Typ.	Max	Unit	
<b>Switching Characteristics</b>							
td(on)	Turn-On Delay Time	NMOS: $V_{DD}=10V$ , $V_{GEN}=4.5V$ , $I_D=0.55A$ , , $R_G=6\Omega$	N-Ch		46		
tr	Turn-On Rise Time		P-Ch		420		
			N-Ch		87		
td(off)	Turn-Off Delay Time		P-Ch		1320		
			N-Ch		776		
tf	Turn-Off Fall Time		P-Ch		8000		
			N-Ch		368		
			P-Ch		8600		
<b>Drain-to-Source Diode Characteristics</b>							
$V_{SD}$	Forward Diode Voltage	$V_{GS}=0V$ , $I_S=0.35A$	N-Ch	0.5	0.74	1.5	V
		$V_{GS}=0V$ , $I_S=-0.25A$	P-Ch	-0.5	-0.80	-1.5	

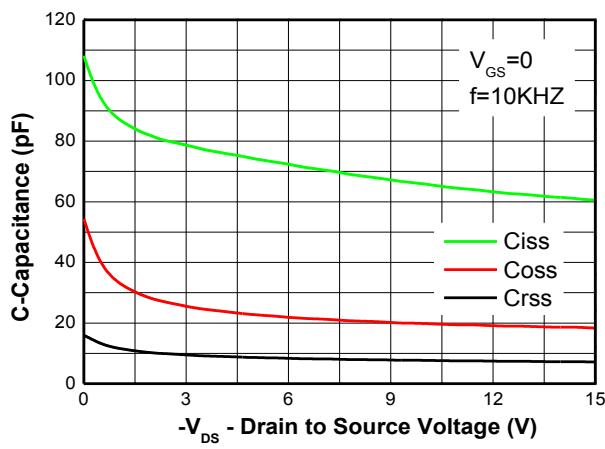
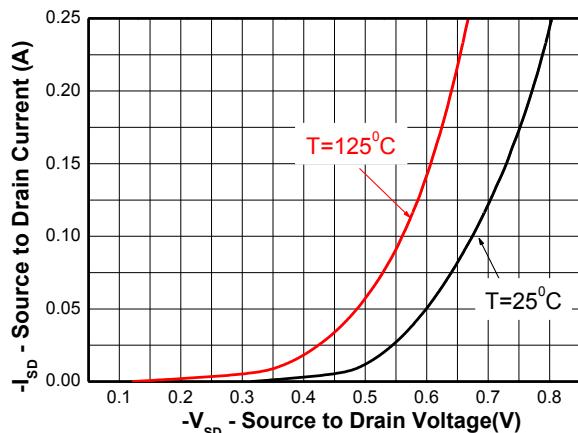
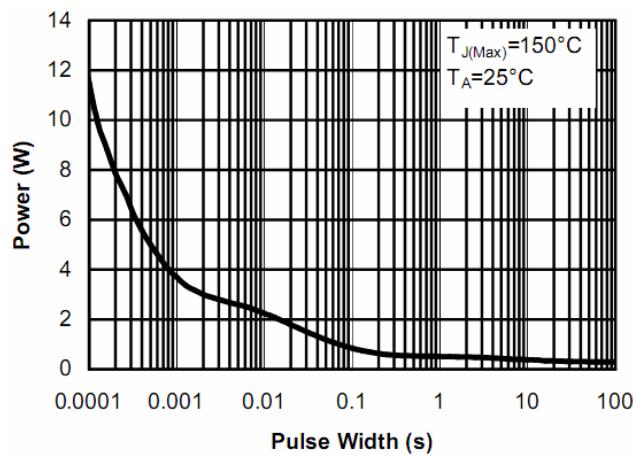
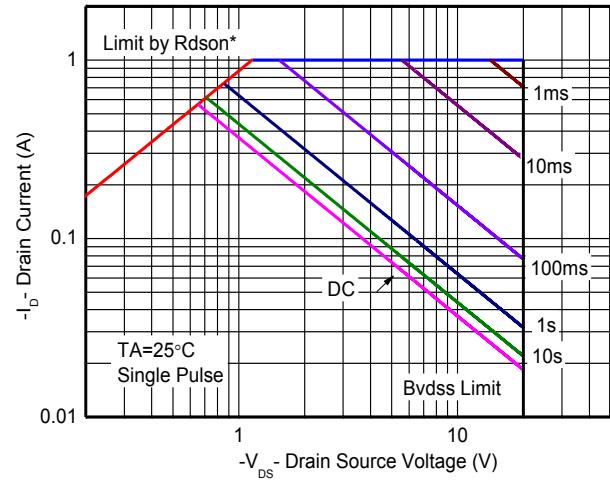
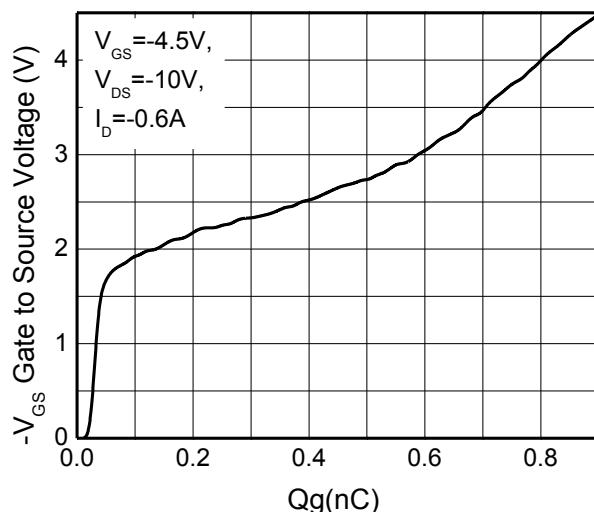
**NMOS Typical Characteristics (Ta=25°C, unless otherwise noted)**


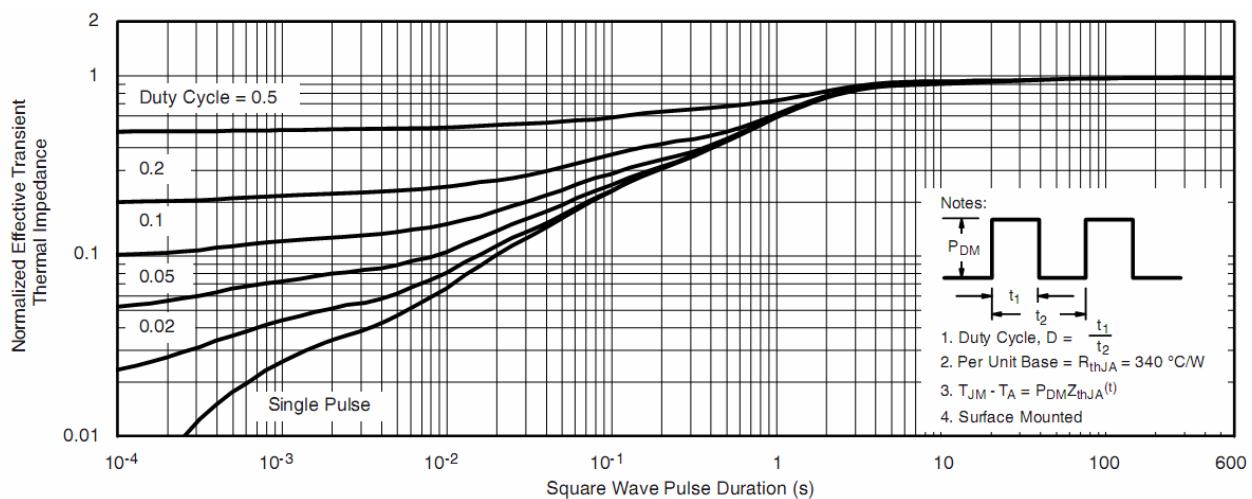




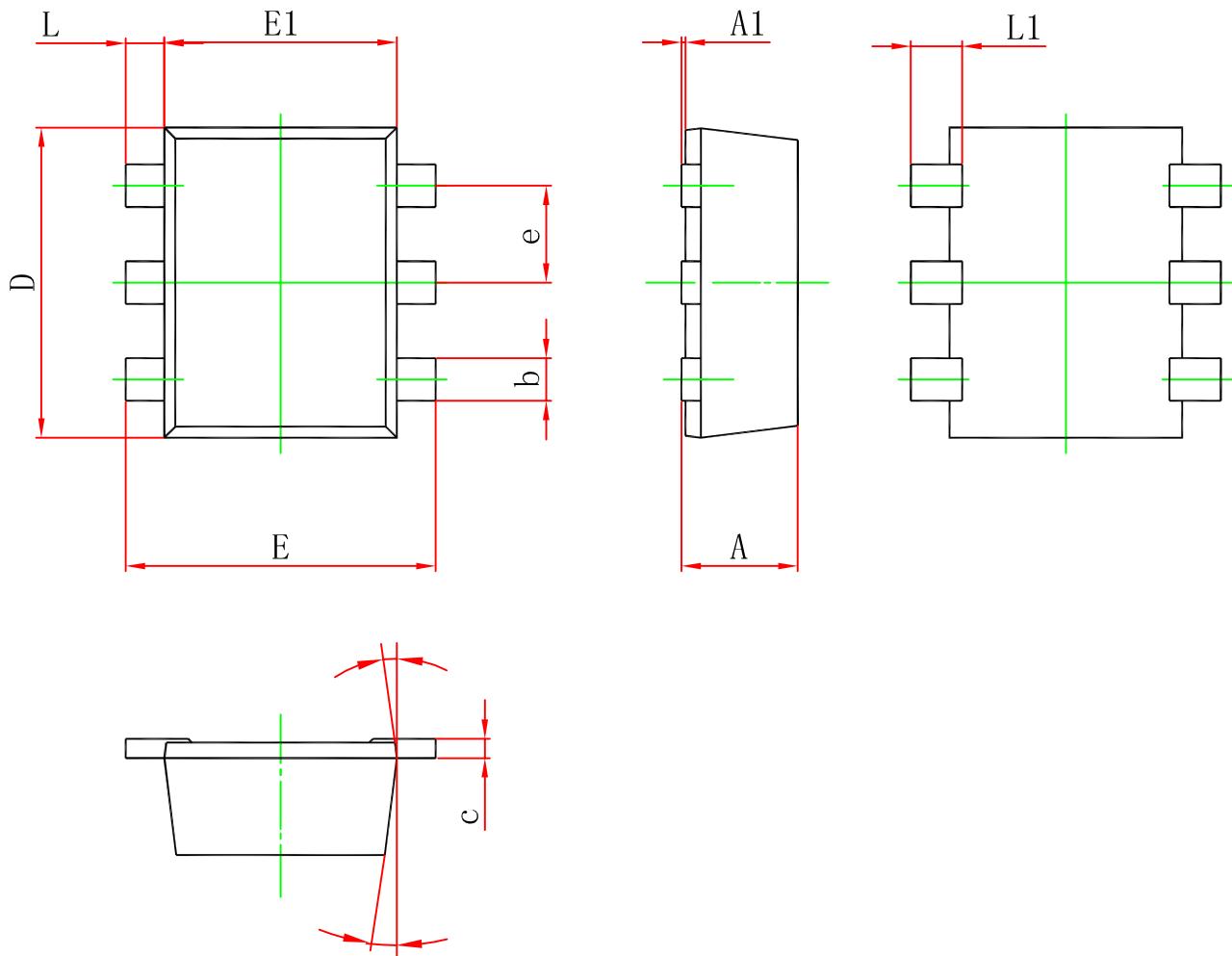
**Transient thermal response (Junction-to-Ambient)**

**PMOS Typical Characteristics (Ta=25°C, unless otherwise noted)**



**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Transient thermal response (Junction-to-Ambient)**

**Package Outline Dimension**
**SOT-563**


<b>Symbol</b>	<b>Dimensions In Millimeters</b>		<b>Dimensions in inches</b>	
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>
A	0.525	0.600	0.021	0.024
A1	0.000	0.050	0.000	0.002
e	0.450	0.550	0.018	0.022
c	0.090	0.160	0.004	0.006
D	1.500	1.700	0.059	0.067
b	0.170	0.270	0.007	0.011
E1	1.100	1.300	0.043	0.051
E	1.500	1.700	0.059	0.067
L	0.100	0.300	0.004	0.012
L1	0.200	0.400	0.008	0.016
0	7 °REF.		7 °REF.	